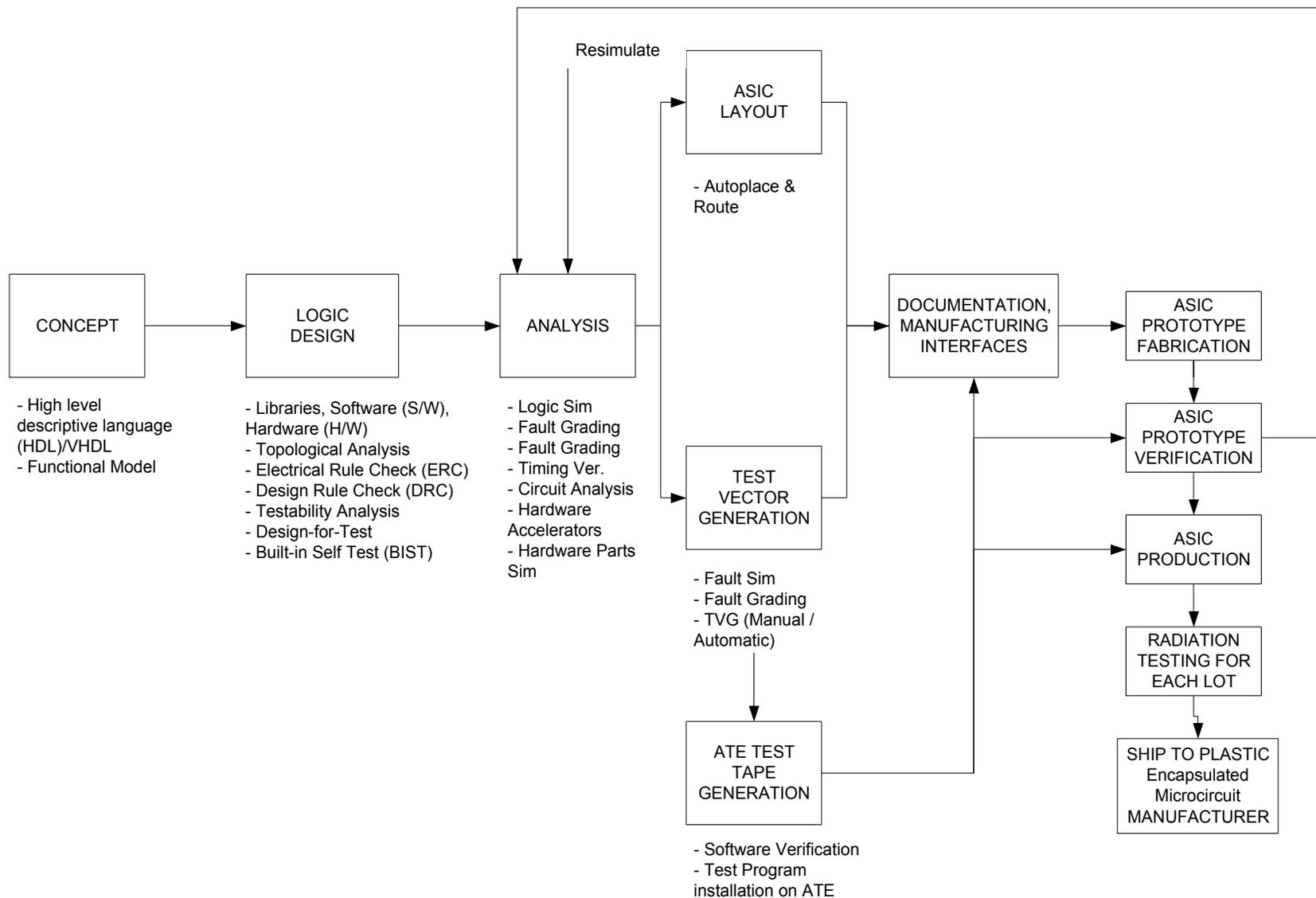
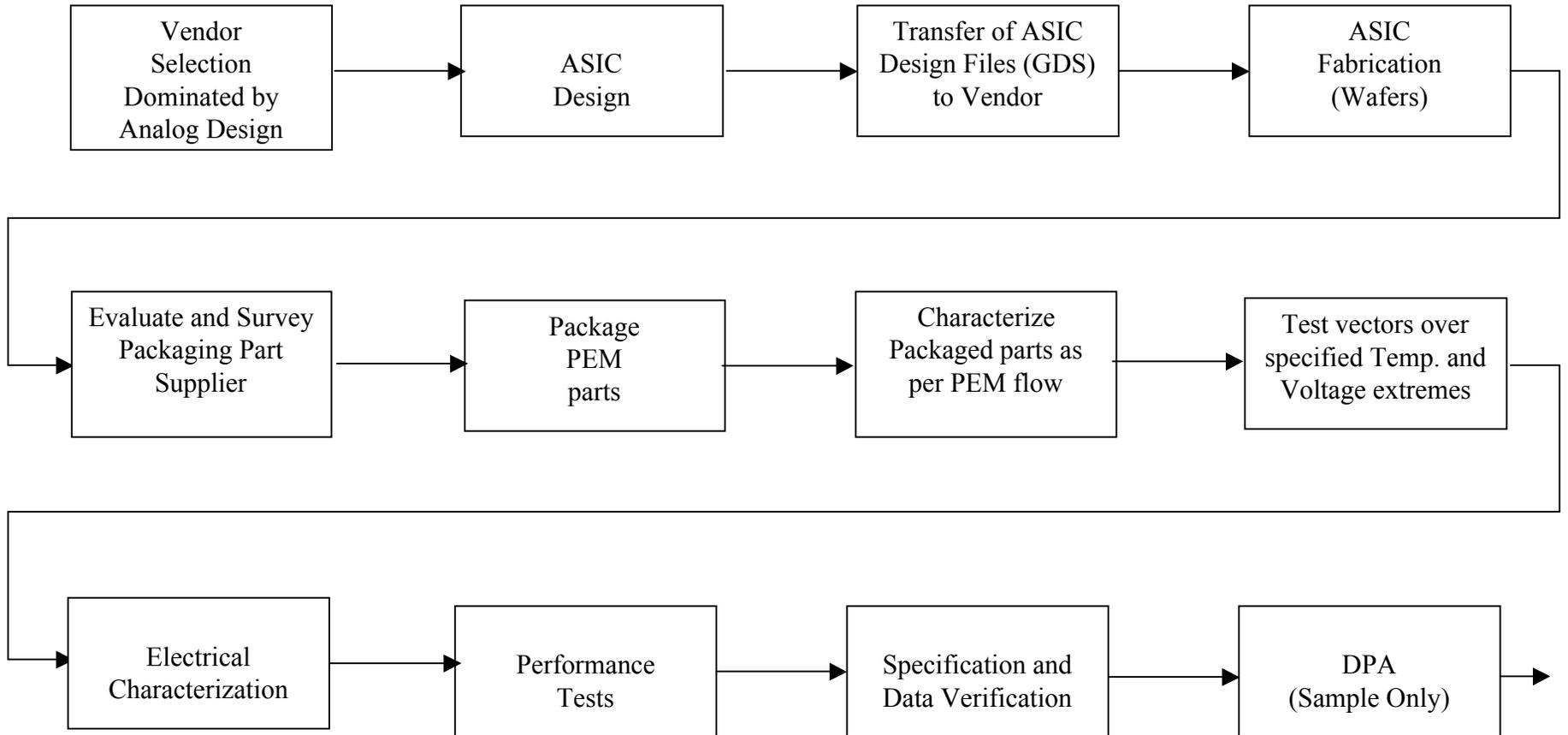


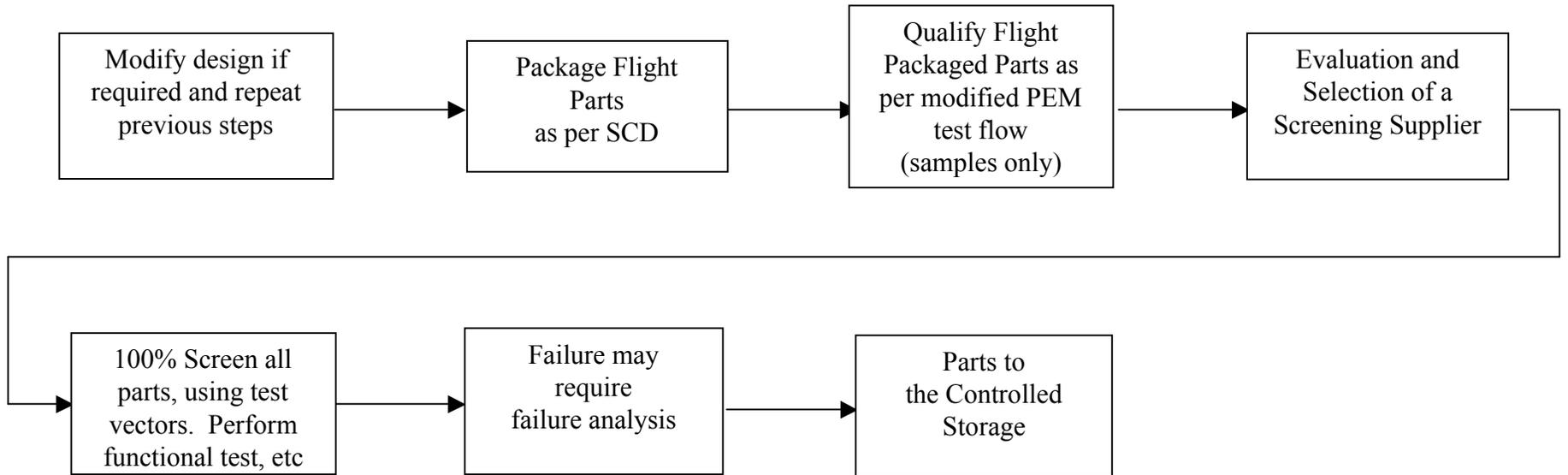
Process Control during Wafer Design and Production



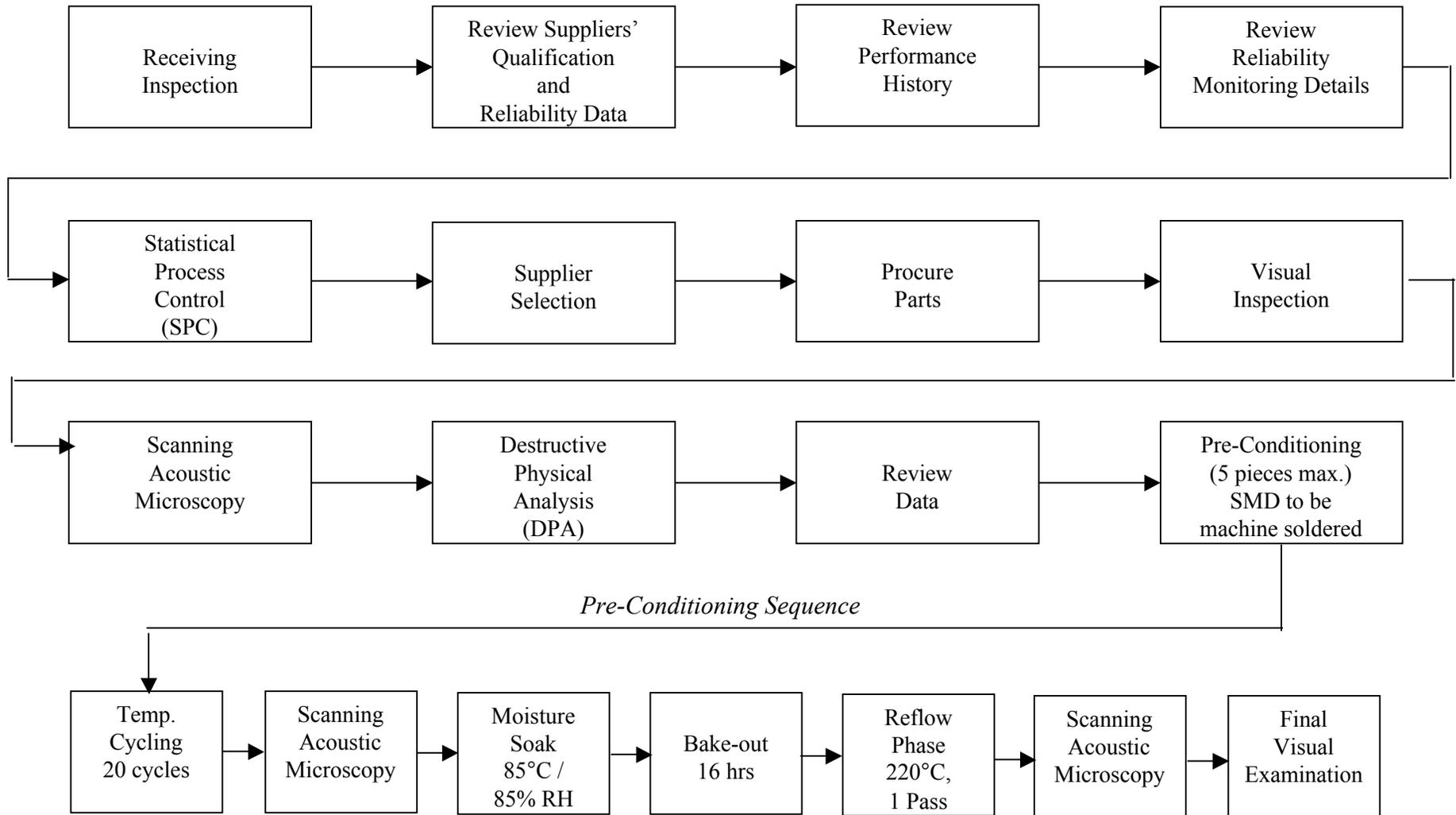
ASIC Part Evaluation (1 of 2)



ASIC Part Evaluation (2 of 2)



QUALIFICATION OF PLASTIC ENCAPSULATED MICROCIRCUITS (1 of 2)



PLASTIC ENCAPSULATED MICROCIRCUITS (2 of 2)

